

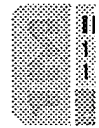
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L4	18449	ross.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 21:27
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L6	2308	(L5 xor L3) (L5 and L3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 21:27
L7	20753	(L6 xor L4) (L6 and L4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 21:27
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L10	31	L7 and L9	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 21:28
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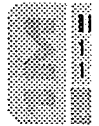
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1 Fuzzy logic-based state-of-health determination of lead acid batteries
Singh, P.; Reisner, D.;

 Telecommunications Energy Conference, 2002. INTELEC. 24th Annual International , 29 Sept.-3 Oct. 2002
 Pages:583 - 590

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1 Wearable sensor system for wireless state-of-health determination cattle

Nagl, L.; Schmitz, R.; Warren, S.; Hildreth, T.S.; Erickson, H.; Andresen, D.;
 Engineering in Medicine and Biology Society, 2003. Proceedings of the 25th Annual International Conference of the IEEE , Volume: 4 , 17-21 Sept. 2003
 Pages:3012 - 3015 Vol.4

[\[Abstract\]](#) [\[PDF Full-Text \(424 KB\)\]](#) **IEEE CNF**
2 Battery state of health monitoring, combining conductance technology with other measurement parameters for real-time battery performance analysis

Cox, D.C.; Perez-Kite, R.;
 Telecommunications Energy Conference, 2000. INTELEC. Twenty-second International , 10-14 Sept. 2000
 Pages:342 - 347

[\[Abstract\]](#) [\[PDF Full-Text \(488 KB\)\]](#) **IEEE CNF**
3 Battery state of health estimation through coup de fouet

Bose, C.S.C.; Laman, F.C.;
 Telecommunications Energy Conference, 2000. INTELEC. Twenty-second International , 10-14 Sept. 2000
 Pages:597 - 601

[\[Abstract\]](#) [\[PDF Full-Text \(312 KB\)\]](#) **IEEE CNF**
4 The detection of the state of health of lead-acid batteries

Spath, V.; Jossen, A.; Doring, H.; Garcke, J.;
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International , 19-23 Oct. 1997
Pages:681 - 686

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5 Monitoring the state of health of VRLA batteries through ohmic measurements

Waters, A.R.; Bullock, K.R.; Bose, C.S.C.;
Telecommunications Energy Conference, 1997. INTELEC 97., 19th
International , 19-23 Oct. 1997
Pages:675 - 680

[\[Abstract\]](#) [\[PDF Full-Text \(428 KB\)\]](#) IEEE CNF

6 Fuzzy logic-based state-of-health determination of lead acid batteries

Singh, P.; Reisner, D.;
Telecommunications Energy Conference, 2002. INTELEC. 24th Annual
International , 29 Sept.-3 Oct. 2002
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7 Payload state of health monitoring design for next generation satellite constellations

Geib, P.L.; Cox, D.D.; Tomasi, A.M.;
Aerospace Conference Proceedings, 2002. IEEE , Volume: 1 , 9-16 March 2002
Pages:1-205 - 1-214 vol.1

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8 Artificial intelligence reads battery state-of-health in three minutes

Buchmann, I.;
Applications and Advances, 2001. The Sixteenth Annual Battery Conference on
12 Jan. 2001
Pages:263 - 265

[\[Abstract\]](#) [\[PDF Full-Text \(316 KB\)\]](#) IEEE CNF

9 Analysis and interpretation of AC-measurements on batteries used to assess state-of-health and capacity-condition

Damlund, I.;
Telecommunications Energy Conference, 1995. INTELEC '95., 17th
International , 29 Oct.-1 Nov. 1995
Pages:828 - 833

[\[Abstract\]](#) [\[PDF Full-Text \(456 KB\)\]](#) IEEE CNF

10 Determining the state-of-health of maintenance-free aircraft batteries

Vutetakis, D.G.; Viswanathan, V.V.;
Battery Conference on Applications and Advances, 1995., Proceedings of the 1
Annual , 10-13 Jan. 1995
Pages:13 - 18

[\[Abstract\]](#) [\[PDF Full-Text \(428 KB\)\]](#) IEEE CNF

11 Analysis and interpretation of conductance measurements used to assess the state-of-health of valve regulated lead acid batteries

Feder, D.O.; Hlavac, M.J.;

Telecommunications Energy Conference, 1994. INTELEC '94., 16th International , 30 Oct.-3 Nov. 1994

Pages:282 - 291

[\[Abstract\]](#) [\[PDF Full-Text \(520 KB\)\]](#) IEEE CNF

12 Field and laboratory studies to assess the state of health of valve-regulated lead acid and other battery technologies using conductance testing

Hlavac, M.J.; Feder, D.O.; Croda, T.G.; Champlin, K.S.;

Telecommunications Energy Conference, 1993. INTELEC '93. 15th International , Volume: 2 , 27-30 Sept. 1993

Pages:375 - 383 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(620 KB\)\]](#) IEEE CNF

13 Field and laboratory studies to assess the state of health of valve-regulated lead acid batteries. I Conductance/capacity correlation studies

Feder, D.O.; Croda, T.G.; Champlin, K.S.; Hlavac, M.J.;

Telecommunications Energy Conference, 1992. INTELEC '92., 14th International , 4-8 Oct. 1992

Pages:218 - 233

[\[Abstract\]](#) [\[PDF Full-Text \(880 KB\)\]](#) IEEE CNF

14 Determination of the state-of-health of VRLA batteries by means of noise measurements

Baert, D.H.J.; Vervaet, A.A.K.;

Telecommunications Energy Conference, 2001. INTELEC 2001. Twenty-Third International , 14-18 Oct. 2001

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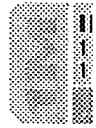
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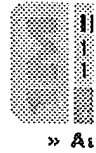
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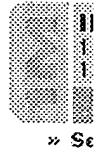
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L1	1	linden-david.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:23
L2	593	huet.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:25
L3	1714	byers.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:32
L4	148	706/1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:33
L5	191	320/127.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:34
L6	0	5 and 2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:35
L7	339	(4 xor 5) (4 and 5)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:36
L8	18449	ross.in.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:37
L9	2	("6072299" "5977750").pn.	USPAT	OR	ON	2004/12/22 18:43
L10	66	("4800336" "4876513" "4885523" "5130659" "5444378" "5455499" "5625291" "5631540" "5721482").PN. OR ("5977750" "6072299").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2004/12/22 18:51

L11	594	(1 xor 2) (1 and 2)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:44
L12	2308	(11 xor 3) (11 and 3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:44
L13	20753	(12 xor 8) (12 and 8)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:44
L14	0	13 and 7	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/22 18:44
L15	68	(9 xor 10) (9 and 10)	US-PGPUB; USPAT; USOCR	OR	ON	2004/12/22 18:52
L16	1	15 and 7	US-PGPUB; USPAT; USOCR	OR	ON	2004/12/22 18:52